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(12) **United States Design Patent**
Wang

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(54) **INFRARED THERMOMETER**

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(**) Term: **15 Years**

(21) Appl. No.: **29/611,986**

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(51) **LOC (11) Cl.** **10-04**

(52) **U.S. Cl.**

USPC **D10/57**

(58) **Field of Classification Search**

USPC **D10/57**

CPC **G01K 1/02; G01K 1/022; G01K 1/024; G01K 1/08; G01K 1/083; G01K 1/086; G01K 3/00-3/14; G01K 2003/145; G01K 13/002; G01K 13/004; G01K 2219/00; G01K 5/04-5/225; G01K 5/22; G01K 221/00; G01J 5/04; G01J 5/041; G01J 5/042; G01J 5/043; G01J 5/044; G01J 5/045; G01J 5/046; G01J 5/047; G01J 5/048; G01J 5/049**

See application file for complete search history.

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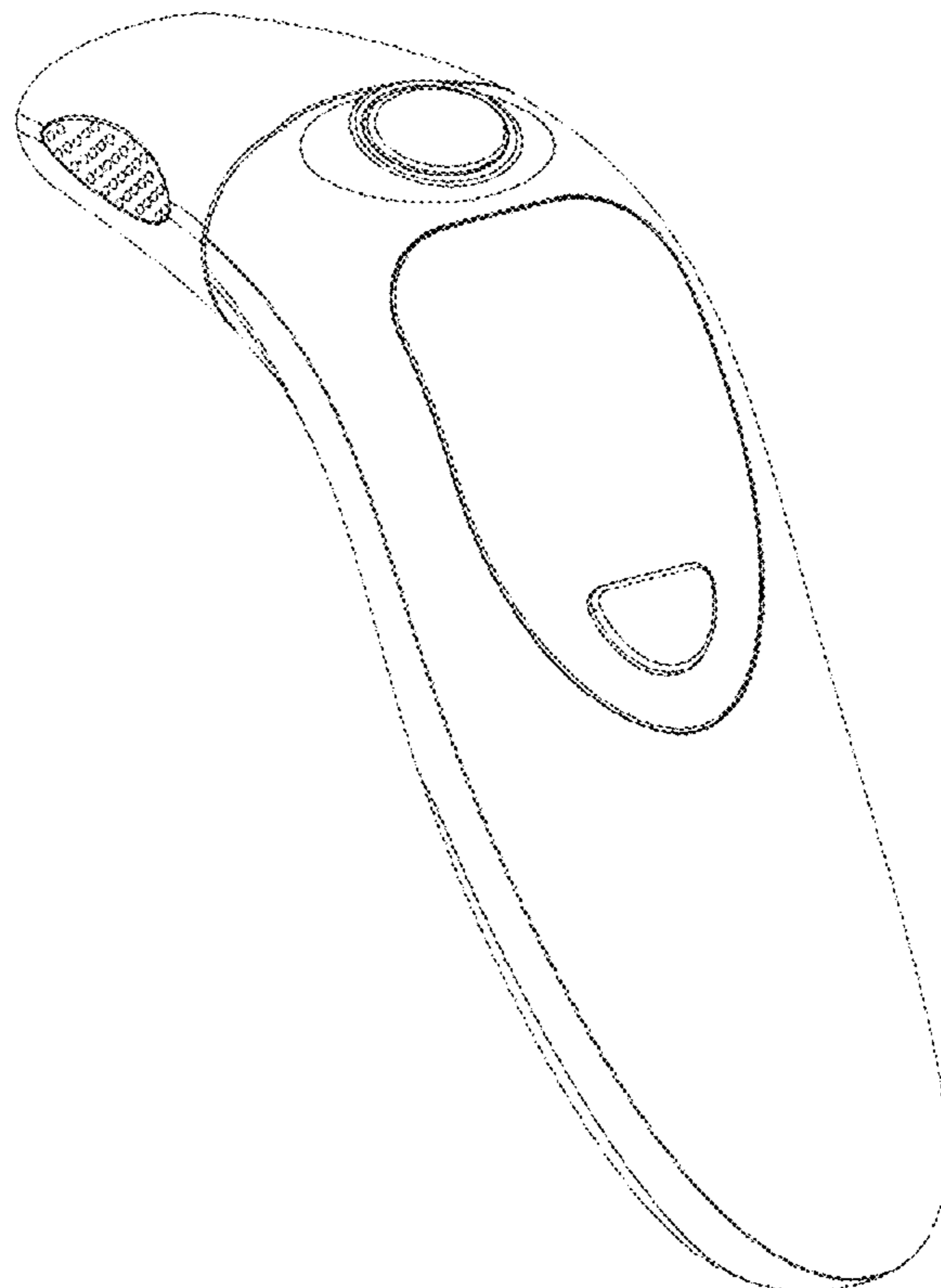
(57) **CLAIM**

The ornamental design for an infrared thermometer, as shown and described.

DESCRIPTION

FIG. 1 is a front perspective view of the infrared thermometer showing my new design;
FIG. 2 is a back view thereof;
FIG. 3 is a front view thereof;
FIG. 4 is a side view thereof;
FIG. 5 is a top view thereof; and,
FIG. 6 is a bottom view thereof.

1 Claim, 6 Drawing Sheets



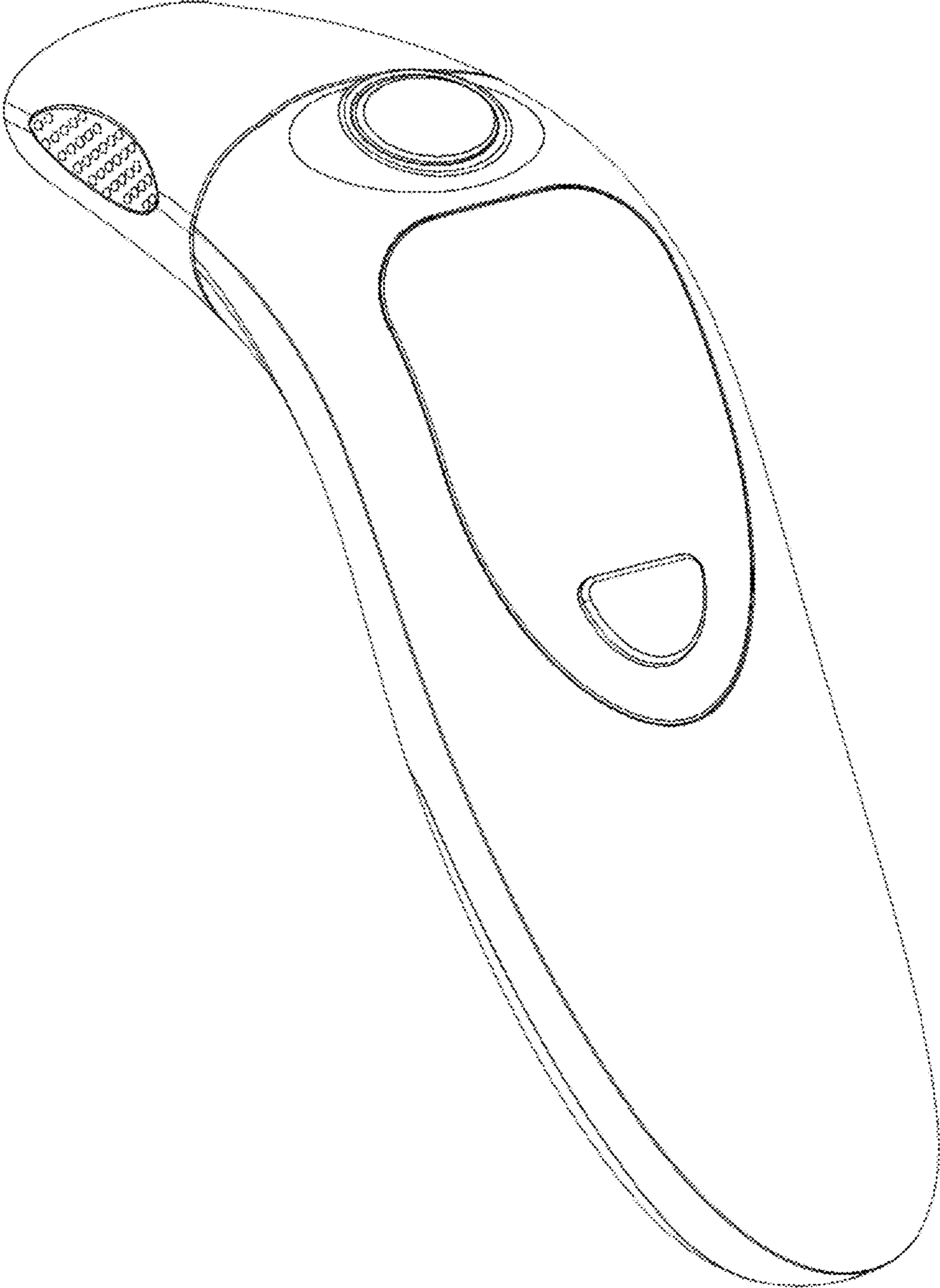


FIG. 1

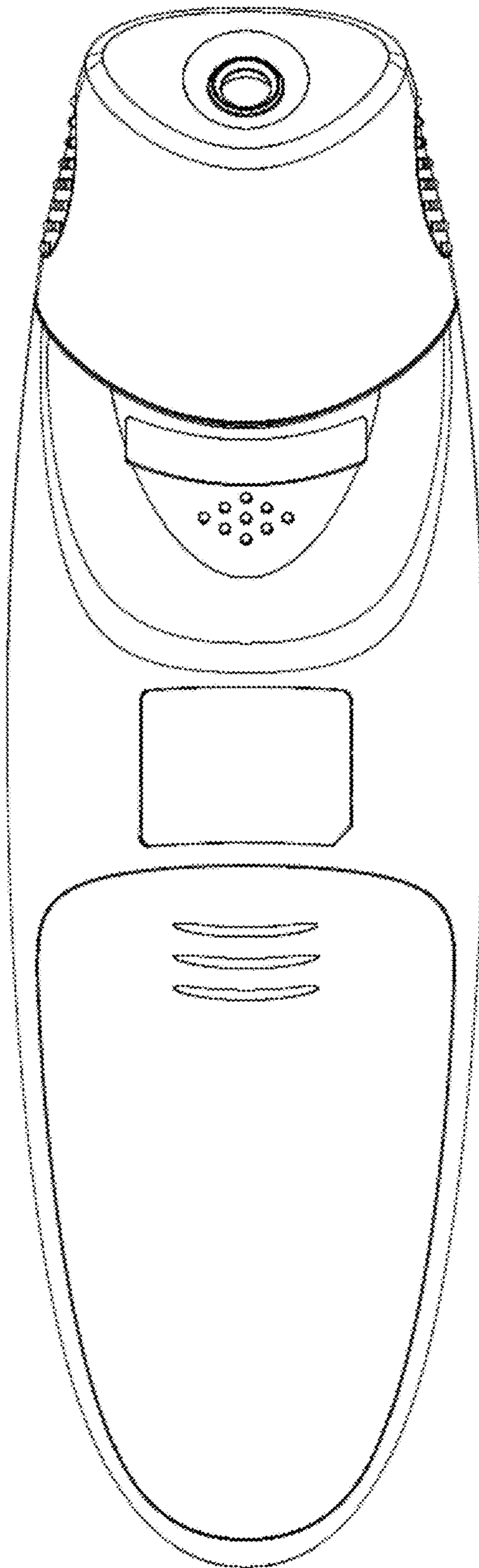


FIG. 2

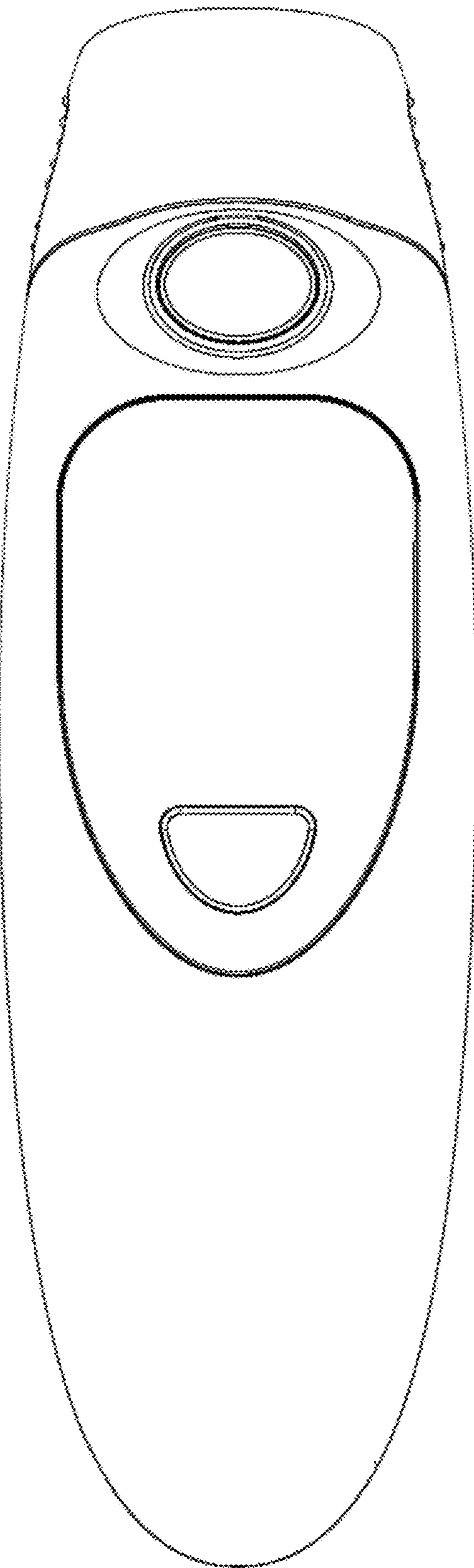


FIG. 3

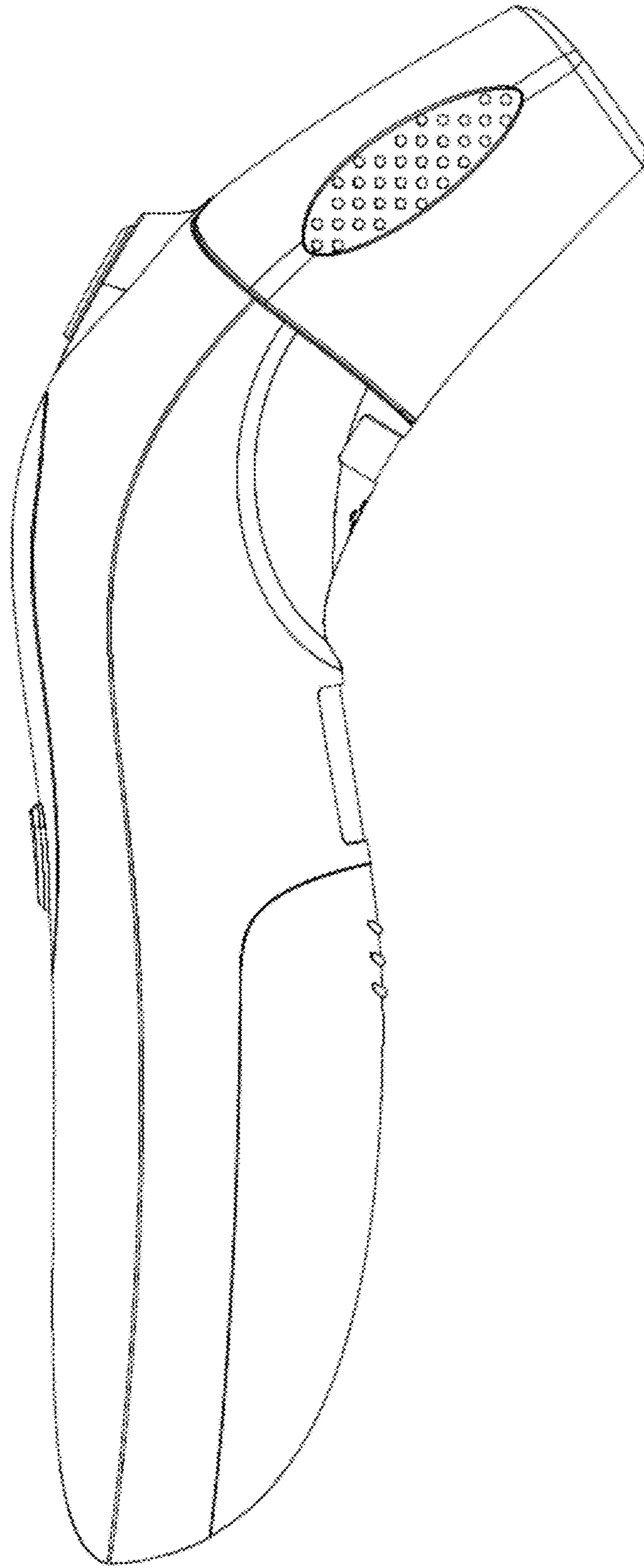


FIG. 4

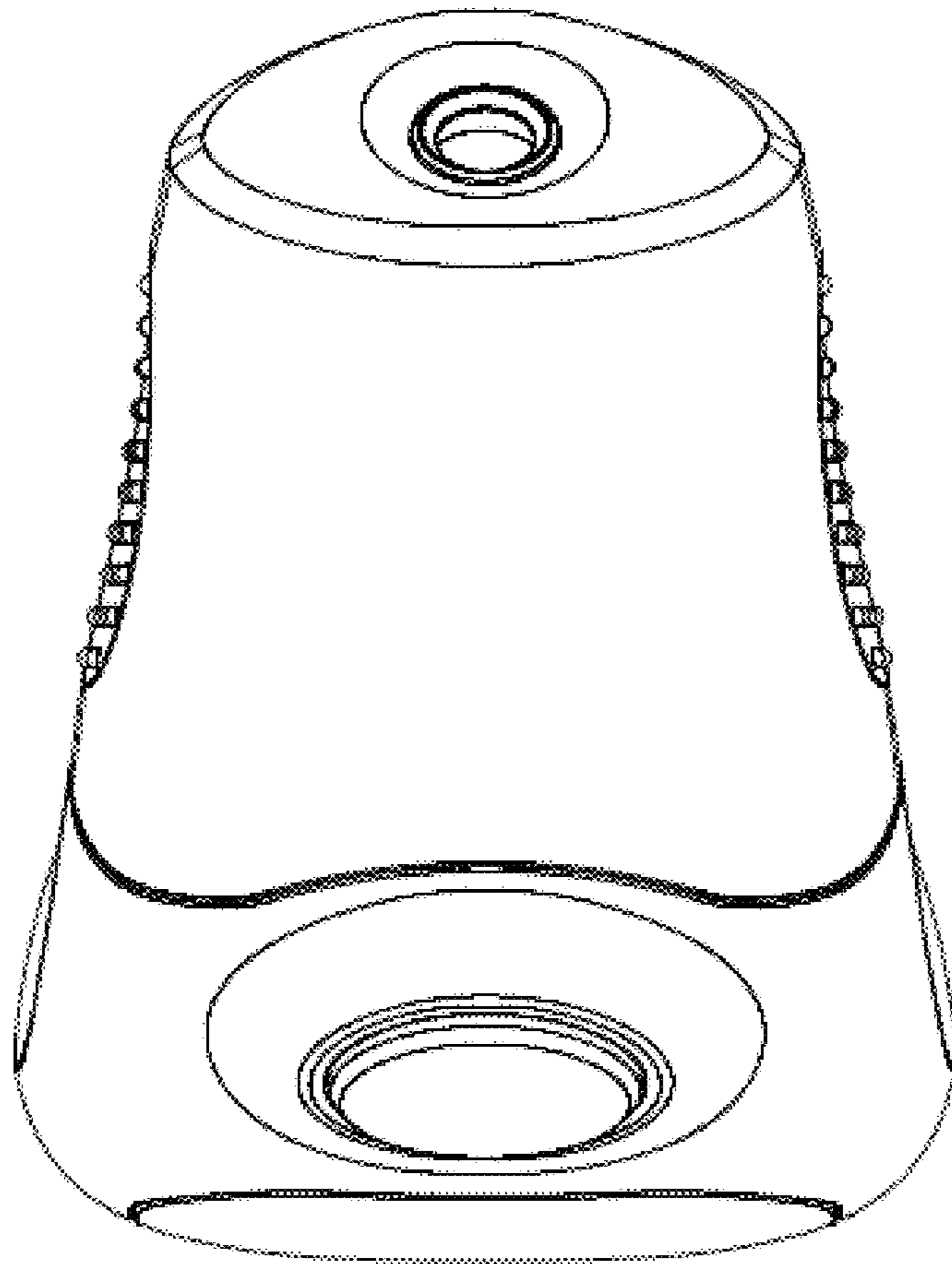


FIG. 5

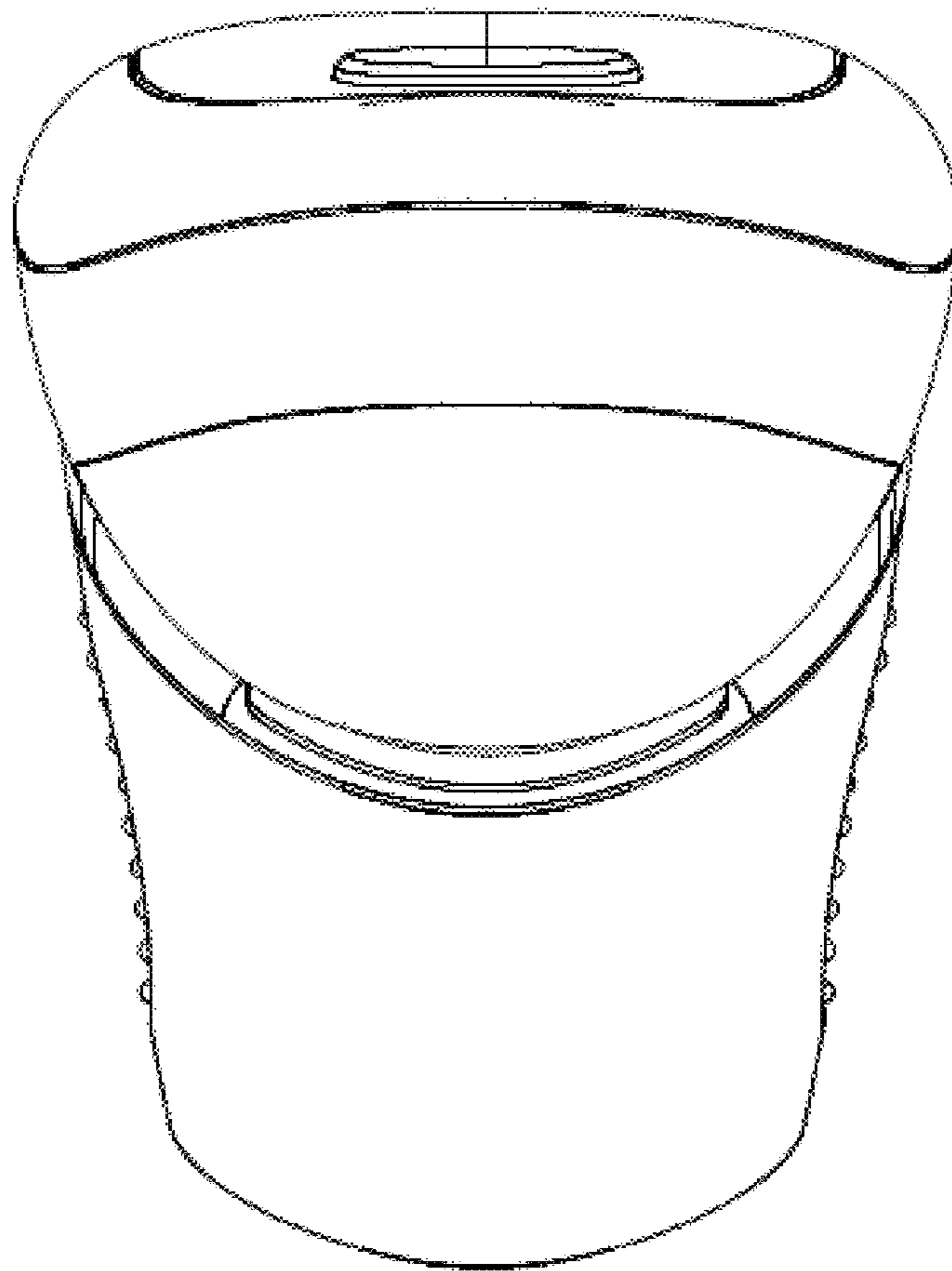


FIG. 6